74ALVT16823

18-bit bus-interface D-type flip-flop with reset and enable; 3-state

Rev. 7 — 25 June 2024   **Product data sheet**

1. General description

The 74ALVT16823 is an 18-bit positive-edge triggered D-type flip-flop with 3-state outputs, reset and enable.

The device can be used as two 9-bit flip-flops or one 18-bit flip-flop. The device features clock (nCP), clock enable ($\overline{nCE}$), master reset ($\overline{nMR}$) and output enable ($\overline{nOE}$, inputs each controlling 9-bits. When $\overline{nCE}$ is LOW, the flip-flops will store the state of their individual D-inputs that meet the set-up and hold time requirements on the LOW-to-HIGH clock (nCP) transition. A HIGH on $\overline{nOE}$ causes the outputs to assume a high-impedance OFF-state. Operation of the $\overline{nOE}$ input does not affect the state of the flip-flops. A LOW on $\overline{nMR}$ will reset the flip-flops LOW. Bus hold data inputs eliminate the need for external pull-up resistors to define unused inputs
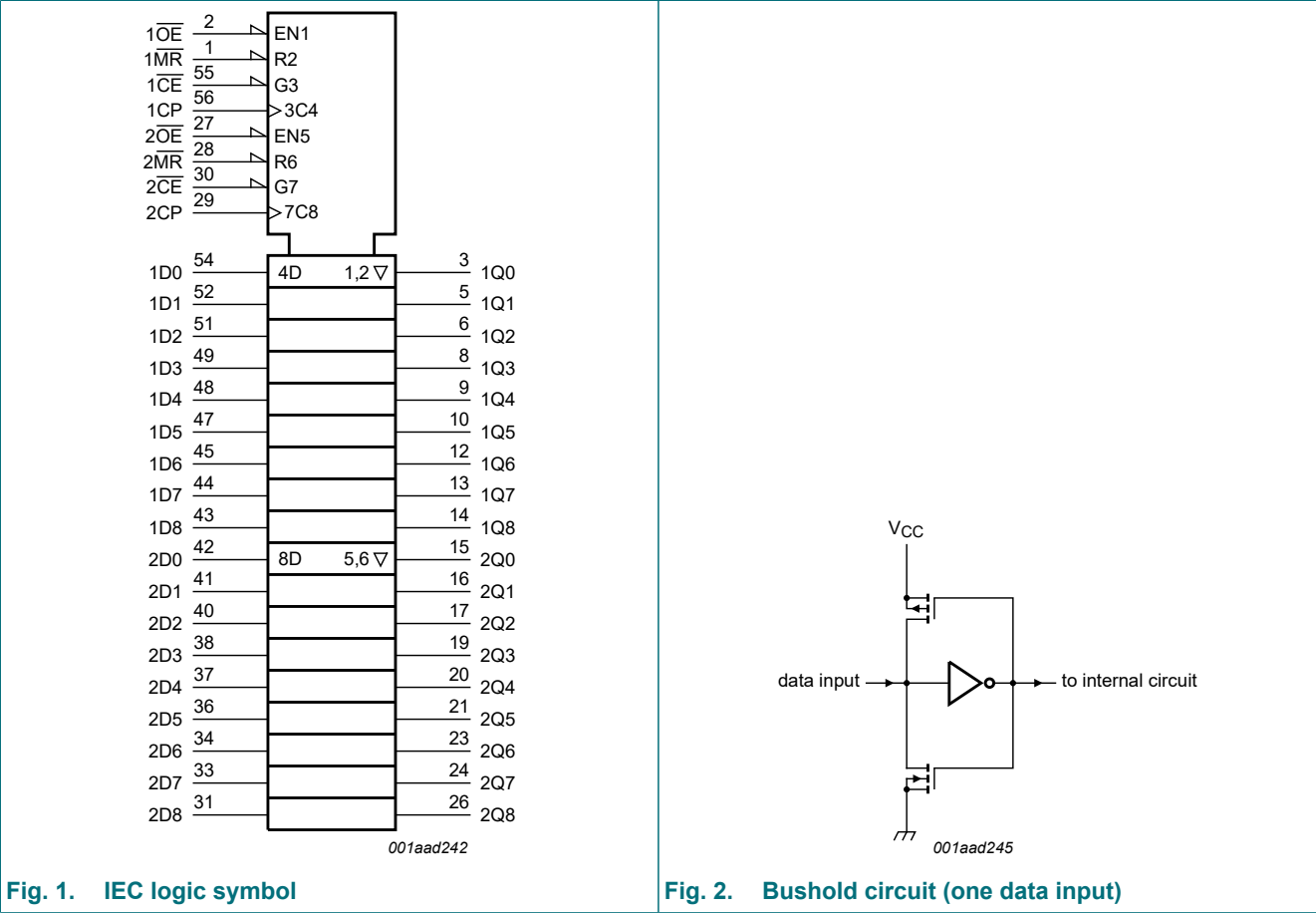
2. Features and benefits

- Wide supply voltage range from 2.3 V to 3.6 V
- Overvoltage tolerant inputs to 5.5 V
- BiCMOS high speed and output drive
- Direct interface with TTL levels
- Bus hold on data inputs
- Power-up 3-state
- I_{OFF} circuitry provides partial Power-down mode operation
- Two sets of high speed parallel registers with positive edge-triggered D-type flip-flops
- Ideal where high speed, light loading, or increased fan-in are required with MOS microprocessors
- Live insertion and extraction permitted
- Power-up reset
- No bus current loading when output is tied to 5 V bus
- Output capability: +64 mA to -32 mA
- Latch-up performance exceeds 500 mA per JESD 78 Class II Level B
- ESD protection:
  - HBM: ANSI/ESDA/JEDEC JS-001 class 2 exceeds 2000 V
  - CDM: ANSI/ESDA/JEDEC JS-002 class C3 exceeds 1000 V
- Specified from -40 °C to 85 °C

3. Ordering information

Table 1. Ordering information

Type number	Package			
	Temperature range	Name	Description	Version
74ALVT16823DGG	-40 °C to +85 °C	TSSOP56	plastic thin shrink small outline package; 56 leads; body width 6.1 mm	SOT364-1

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4. Functional diagram

1OE — 2 → EN1		
1MR — 1 → R2		
1CE — 55 → G3		
1CP — 56 → >3C4		
2OE — 27 → EN5		
2MR — 28 → R6		
2CE — 30 → G7		
2CP — 29 → >7C8		

1D0	54	4D 1,2 ▽	3	1Q0
1D1	52		5	1Q1
1D2	51		6	1Q2
1D3	49		8	1Q3
1D4	48		9	1Q4
1D5	47		10	1Q5
1D6	45		12	1Q6
1D7	44		13	1Q7
1D8	43		14	1Q8
2D0	42	8D 5,6 ▽	15	2Q0
2D1	41		16	2Q1
2D2	40		17	2Q2
2D3	38		19	2Q3
2D4	37		20	2Q4
2D5	36		21	2Q5
2D6	34		23	2Q6
2D7	33		24	2Q7
2D8	31		26	2Q8

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Fig. 1.   IEC logic symbol

V_{CC}

data input → [inverter] → to internal circuit

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Fig. 2.   Bushold circuit (one data input)

Fig. 3.   Logic diagram

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5. Pinning information

5.1. Pinning

1MR	1	56	1CP
1OE	2	55	1CE
1Q0	3	54	1D0
GND	4	53	GND
1Q1	5	52	1D1
1Q2	6	51	1D2
V$_{CC}$	7	50	V$_{CC}$
1Q3	8	49	1D3
1Q4	9	48	1D4
1Q5	10	47	1D5
GND	11	46	GND
1Q6	12	45	1D6
1Q7	13	44	1D7
1Q8	14	43	1D8
2Q0	15	42	2D0
2Q1	16	41	2D1
2Q2	17	40	2D2
GND	18	39	GND
2Q3	19	38	2D3
2Q4	20	37	2D4
2Q5	21	36	2D5
V$_{CC}$	22	35	V$_{CC}$
2Q6	23	34	2D6
2Q7	24	33	2D7
GND	25	32	GND
2Q8	26	31	2D8
2OE	27	30	2CE
2MR	28	29	2CP

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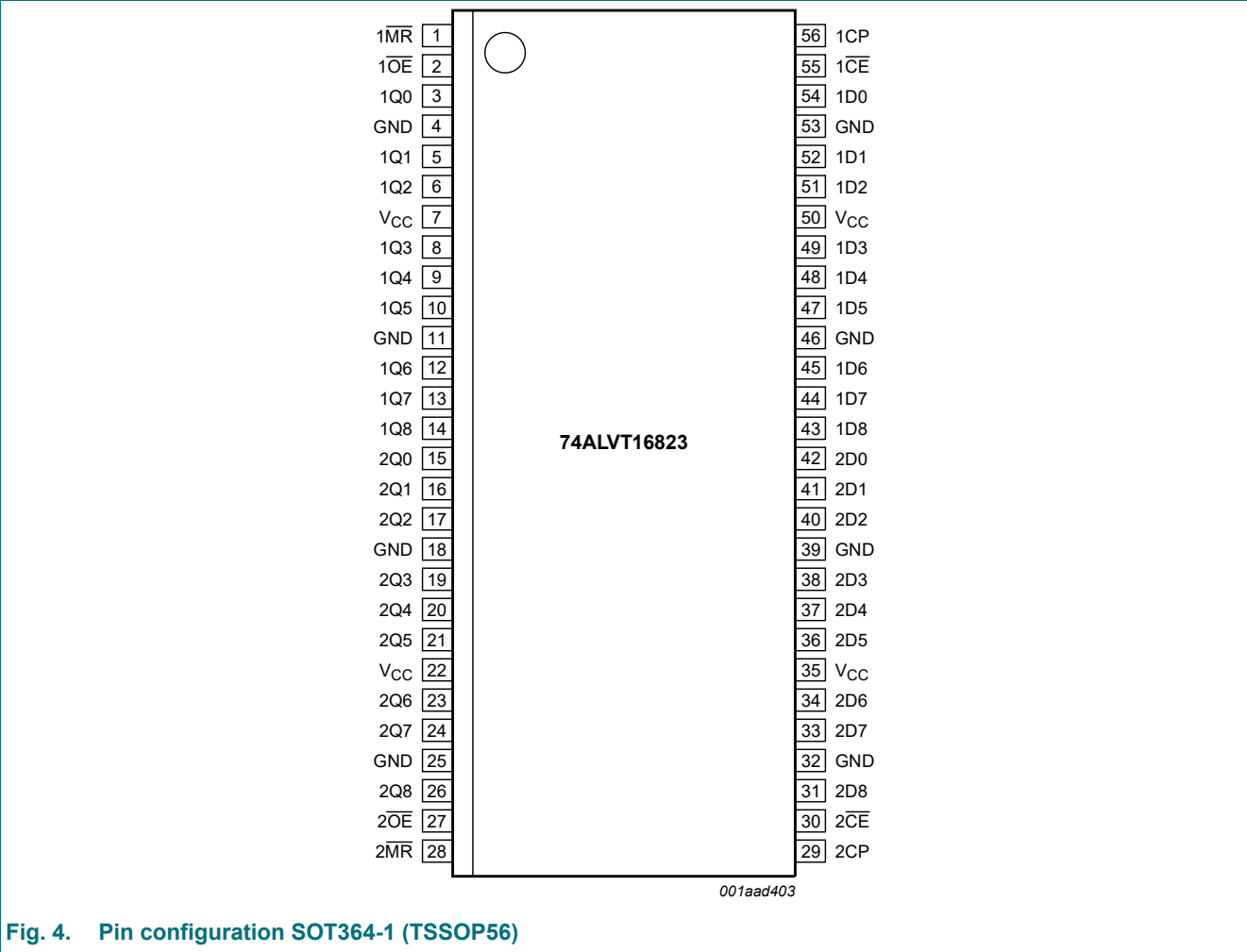
Fig. 4.   Pin configuration SOT364-1 (TSSOP56)

5.2. Pin description

Table 2. Pin description

Symbol	Pin	Description
1D0, 1D1, 1D2, 1D3, 1D4, 1D5, 1D6, 1D7, 1D8	54, 52, 51, 49, 48, 47, 45, 44, 43	data inputs
1Q0, 1Q1, 1Q2, 1Q3, 1Q4, 1Q5, 1Q6, 1Q7, 1Q8	3, 5, 6, 8, 9, 10, 12, 13, 14	data outputs
2D0, 2D1, 2D2, 2D3, 2D4, 2D5, 2D6, 2D7, 2D8	42, 41, 40, 38, 37, 36, 34, 33, 31	data inputs
2Q0, 2Q1, 2Q2, 2Q3, 2Q4, 2Q5, 2Q6, 2Q7, 2Q8	15, 16, 17, 19, 20, 21, 23, 24, 26	data outputs
1MR, 2MR	1, 28	master reset input (active-LOW)
1OE, 2OE	2, 27	output enable inputs (active LOW)
1CP, 2CP	56, 29	clock pulse inputs (active rising edge)
1CE, 2CE	55, 30	clock enable input (active-LOW)
GND	4, 11, 18, 25, 32, 39, 46, 53	ground (0 V)
V$_{CC}$	7, 22, 35, 50	supply voltage

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6. Functional description

Table 3. Function table

H = HIGH voltage level; h = HIGH voltage level one set-up time prior to the LOW-to-HIGH clock transition;

L = LOW voltage level; l = LOW voltage level one set-up time prior to the LOW-to-HIGH clock transition;

NC = no change; X = don't care; Z = high-impedance OFF-state;

↑ = LOW-to-HIGH clock transition; $\overline{\uparrow}$ = not a LOW-to-HIGH clock transition.

Operating mode	Input					Output
	$n\overline{OE}$	$n\overline{MR}$	$n\overline{CE}$	nCP	nDn	nQn
clear	L	L	X	X	X	L
load and read data	L	H	L	↑	h	H
					l	L
hold	L	H	H	$\overline{\uparrow}$	X	NC
high-impedance	H	X	X	X	X	Z

7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134); voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		Min	Max	Unit
V_{CC}	supply voltage			-0.5	+4.6	V
V_I	input voltage		[1]	-0.5	+7.0	V
V_O	output voltage	output in OFF-state or HIGH-state	[1]	-0.5	+7.0	V
I_{IK}	input clamping current	$V_I < 0$ V		-	-50	mA
I_{OK}	output clamping current	$V_O < 0$ V		-	-50	mA
I_O	output current	output in LOW-state		-	128	mA
		output in HIGH-state		-64	-	mA
T_{stg}	storage temperature			-65	+150	°C
T_j	junction temperature		[2]	-	150	°C

[1] The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.
[2] The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability.

8. Recommended operating conditions

Table 5. Recommended operating conditions

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V_{CC} = 2.5 V						
V_{CC}	supply voltage		2.3	-	2.7	V
V_I	input voltage		0	-	5.5	V
I_{OH}	HIGH-level output current		-	-	-8	mA
I_{OL}	LOW-level output current	none	-	-	8	mA
		current duty cycle ≤ 50 %; f ≥ 1 kHz	-	-	24	mA
$\Delta t/\Delta v$	input transition rise or fall rate	outputs enabled	-	-	10	ns/V
T_{amb}	ambient temperature	in free air	-40	-	+85	°C

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18-bit bus-interface D-type flip-flop with reset and enable; 3-state

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V$_{CC}$ = 3.3 V						
V$_{CC}$	supply voltage		3.0	-	3.6	V
V$_I$	input voltage		0	-	5.5	V
I$_{OH}$	HIGH-level output current		-	-	-32	mA
I$_{OL}$	LOW-level output current	none	-	-	32	mA
		current duty cycle ≤ 50 %; f ≥ 1 kHz	-	-	64	mA
Δt/Δv	input transition rise or fall rate	outputs enabled	-	-	10	ns/V
T$_{amb}$	ambient temperature	in free air	-40	-	+85	°C

9. Static characteristics

Table 6. Static characteristics

At recommended operating conditions; Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	T$_{amb}$ = −40 °C to +85 °C			Unit
			Min	**Typ**[1]	**Max**	
V$_{CC}$ = 2.5 V ± 0.2 V						
V$_{IK}$	input clamping voltage	V$_{CC}$ = 2.3 V; I$_{IK}$ = -18 mA	-	-0.85	-1.2	V
V$_{IH}$	HIGH-level input voltage		1.7	-	-	V
V$_{IL}$	LOW-level input voltage		-	-	0.7	V
V$_{OH}$	HIGH-level output voltage	V$_{CC}$ = 2.3 V to 2.7 V; I$_O$ = -100 µA	V$_{CC}$ - 0.2	V$_{CC}$	-	V
		V$_{CC}$ = 2.3 V; I$_O$ = -8 mA	1.8	2.5	-	V
V$_{OL}$	LOW-level output voltage	V$_{CC}$ = 2.3 V; I$_O$ = 100 µA	-	0.07	0.2	V
		V$_{CC}$ = 2.3 V; I$_O$ = 24 mA	-	0.3	0.5	V
		V$_{CC}$ = 2.3 V; I$_O$ = 8 mA	-	-	0.4	V
V$_{OL(pu)}$	power-up LOW-level output voltage	V$_{CC}$ = 2.7 V; I$_O$ = 1 mA; V$_I$ = V$_{CC}$ or GND [2]	-	-	0.55	V
I$_I$	input leakage current	control pins				
		V$_{CC}$ = 2.7 V; V$_I$ = V$_{CC}$ or GND	-	0.1	±1	µA
		V$_{CC}$ = 0 V to 2.7 V; V$_I$ = 5.5 V	-	0.1	10	µA
		I/O data pins [3]				
		V$_{CC}$ = 2.7 V; V$_I$ = V$_{CC}$	-	0.1	1	µA
		V$_{CC}$ = 2.7 V; V$_I$ = 0 V	-	+0.1	-5	µA
I$_{OFF}$	power-off leakage current	V$_{CC}$ = 0 V; V$_I$ or V$_O$ = 0 V to 4.5 V	-	+0.1	±100	µA
I$_{BHL}$	bus hold LOW current	data inputs; V$_{CC}$ = 2.3 V; V$_I$ = 0.7 V [4]	-	100	-	µA
I$_{BHH}$	bus hold HIGH current	data inputs; V$_{CC}$ = 2.3 V; V$_I$ = 1.7 V [4]	-	-70	-	µA
I$_{EX}$	external current	output HIGH-state when V$_O$ > V$_{CC}$; V$_O$ = 5.5 V; V$_{CC}$ = 2.3 V	-	10	125	µA
I$_{O(pu\pd)}$	power-up/power-down output current	V$_{CC}$ ≤ 1.2 V; V$_O$ = 0.5 V to V$_{CC}$; V$_I$ = GND or V$_{CC}$ [5]	-	1	±100	µA
I$_{OZ}$	OFF-state output current	V$_{CC}$ = 2.7 V; V$_I$ = V$_{IL}$ or V$_{IH}$				
		output HIGH state; V$_O$ = 2.3 V	-	0.5	5	µA
		output LOW-state; V$_O$ = 0.5 V	-	+0.5	-5	µA

18-bit bus-interface D-type flip-flop with reset and enable; 3-state

Symbol	Parameter	Conditions		T_{amb} = −40 °C to +85 °C			Unit
				Min	Typ[1]	Max	
I_{CC}	supply current	V_{CC} = 2.7 V; V_I = GND or V_{CC}; I_O = 0 A					
		outputs HIGH-state		-	0.04	0.1	mA
		outputs LOW-state		-	2.7	4.5	mA
		outputs disabled	[6]	-	0.04	0.1	mA
ΔI_{CC}	additional supply current	per input pin; V_{CC} = 2.3 V to 2.7 V; one input at V_{CC} - 0.6 V, other inputs at V_{CC} or GND	[7]	-	0.04	0.4	mA
C_I	input capacitance	V_I = 0 V or V_{CC}		-	3	-	pF
C_O	output capacitance	$V_{I/O}$ = 0 V or 3.0 V		-	9	-	pF
V_{CC} = 3.3 V ± 0.3 V							
V_{IK}	input clamping voltage	V_{CC} = 3.0 V; I_{IK} = -18 mA		-	-0.85	-1.2	V
V_{IH}	HIGH-level input voltage			2.0	-	-	V
V_{IL}	LOW-level input voltage			-	-	0.8	V
V_{OH}	HIGH-level output voltage	V_{CC} = 3.0 V to 3.6 V; I_O = -100 µA		V_{CC} - 0.2	V_{CC}	-	V
		V_{CC} = 3.0 V; I_O = -32 mA		2.0	2.3	-	V
V_{OL}	LOW-level output voltage	V_{CC} = 3.0 V; I_O = 100 µA		-	0.07	0.2	V
		V_{CC} = 3.0 V; I_O = 16 mA		-	0.25	0.4	V
		V_{CC} = 3.0 V; I_O = 32 mA		-	0.3	0.5	V
		V_{CC} = 3.0 V; I_O = 64 mA		-	0.4	0.55	V
$V_{OL(pu)}$	power-up LOW-level output voltage	V_{CC} = 3.6 V; I_O = 1 mA; V_I = V_{CC} or GND	[2]	-	-	0.55	V
I_I	input leakage current	control pins					
		V_{CC} = 3.6 V; V_I = V_{CC} or GND		-	0.1	±1	µA
		V_{CC} = 0 V or 3.6 V; V_I = 5.5 V		-	0.1	10	µA
		I/O data pins	[3]				
		V_{CC} = 3.6 V; V_I = V_{CC}		-	0.5	1	µA
		V_{CC} = 3.6 V; V_I = 0 V		-	+0.1	-5	µA
I_{OFF}	power-off leakage current	V_{CC} = 0 V; V_I or V_O = 0 V to 4.5 V		-	0.1	±100	µA
I_{BHL}	bus hold LOW current	data inputs; V_{CC} = 3 V; V_I = 0.8 V		75	130	-	µA
I_{BHH}	bus hold HIGH current	data inputs; V_{CC} = 3 V; V_I = 2.0 V		-75	-140	-	µA
I_{BHLO}	bus hold LOW overdrive current	data inputs; V_{CC} = 3.6 V; V_I = 0 V to 3.6 V	[8]	500	-	-	µA
I_{BHHO}	bus hold HIGH overdrive current	data inputs; V_{CC} = 3.6 V; V_I = 0 V to 3.6 V	[8]	−500	-	-	µA
I_{EX}	external current	output HIGH-state when V_O > V_{CC}; V_O = 5.5 V; V_{CC} = 3.0 V		-	10	125	µA
$I_{O(pu\pd)}$	power-up/power-down output current	V_{CC} ≤ 1.2 V; V_O = 0.5 V to V_{CC}; V_I = GND or V_{CC}	[9]	-	1	±100	µA
I_{OZ}	OFF-state output current	V_{CC} = 3.6 V; V_I = V_{IL} or V_{IH}					
		output HIGH state; V_O = 3.0 V		-	0.5	5	µA
		output LOW-state; V_O = 0.5 V		-	+0.5	-5	µA

Symbol	Parameter	Conditions		T_{amb} = −40 °C to +85 °C			Unit
				Min	Typ[1]	Max	
I_{CC}	supply current	V_{CC} = 3.6 V; V_I = GND or V_{CC}; I_O = 0 A					
		outputs HIGH-state		-	0.06	0.1	mA
		outputs LOW-state		-	3.9	5.5	mA
		outputs disabled	[6]	-	0.06	0.1	mA
ΔI_{CC}	additional supply current	per input pin; V_{CC} = 3 V to 3.6 V; one input at V_{CC} - 0.6 V, other inputs at V_{CC} or GND	[7]	-	0.04	0.4	mA
C_I	input capacitance	V_I = 0 V or V_{CC}		-	3	-	pF
C_O	output capacitance	$V_{I/O}$ = 0 V or 3.0 V		-	9	-	pF

[1] All typical values for V_{CC} = 2.5 V ± 0.2 V are measured at V_{CC} = 2.5 V and T_{amb} = 25 °C.
    All typical values for V_{CC} = 3.3 V ± 0.3 V are measured at V_{CC} = 3.3 V and T_{amb} = 25 °C.
[2] For valid test results, data must not be loaded into the flip-flops after applying power.
[3] Unused pins at V_{CC} or GND.
[4] Not guaranteed.
[5] This parameter is valid for any V_{CC} between 0 V and 1.2 V with a transition time of up to 10 ms.
    From V_{CC} = 1.2 V to V_{CC} = 2.5 V ± 0.2 V a transition time of 100 µs is permitted. This parameter is valid for T_{amb} = 25 °C only.
[6] I_{CC} is measured with outputs pulled up to V_{CC} or pulled down to ground.
[7] This is the increase in supply current for each input at the specified voltage level other than V_{CC} or GND.
[8] This is the bus hold overdrive current required to force the input to the opposite logic state.
[9] This parameter is valid for any V_{CC} between 0 V and 1.2 V with a transition time of up to 10 ms.
    From V_{CC} = 1.2 V to V_{CC} = 3.3 V ± 0.3 V a transition time of 100 µs is permitted. This parameter is valid for T_{amb} = 25 °C only.

10. Dynamic characteristics

Table 7. Dynamic characteristics
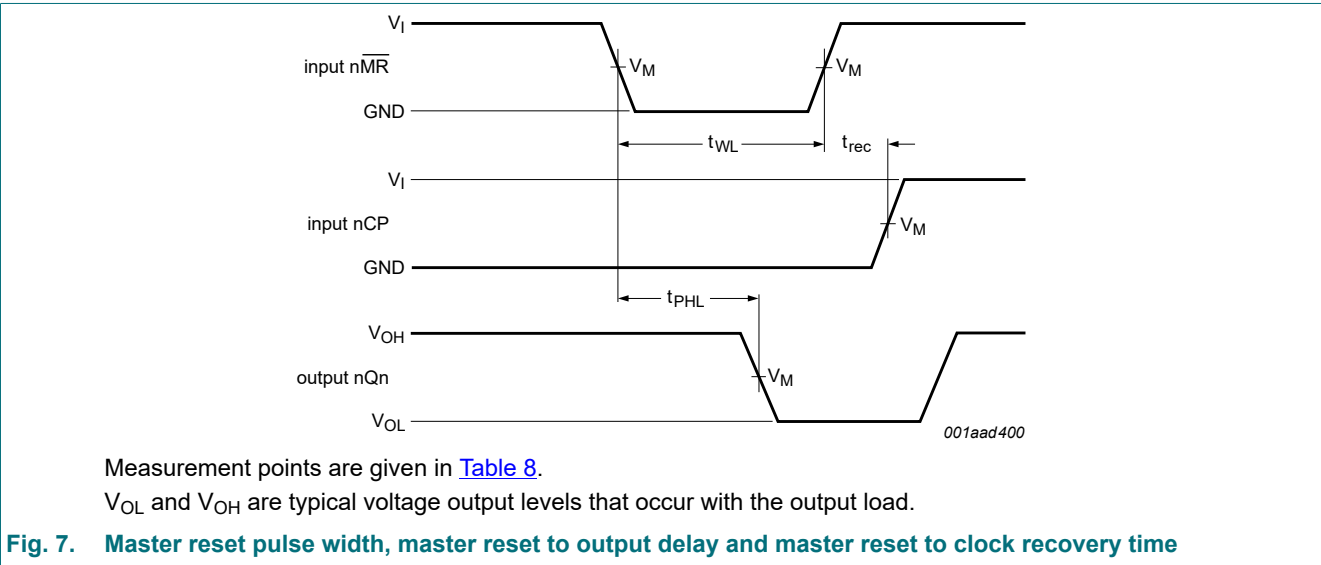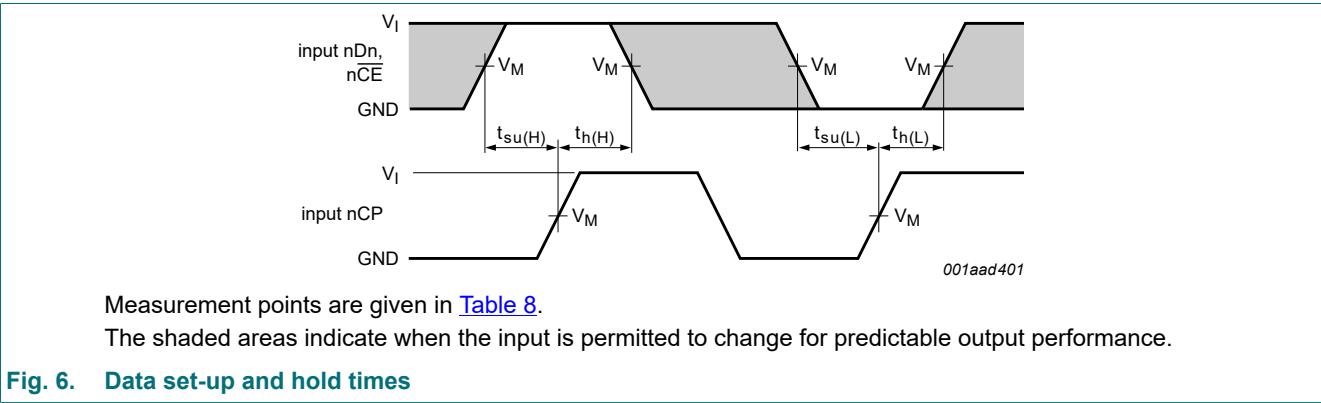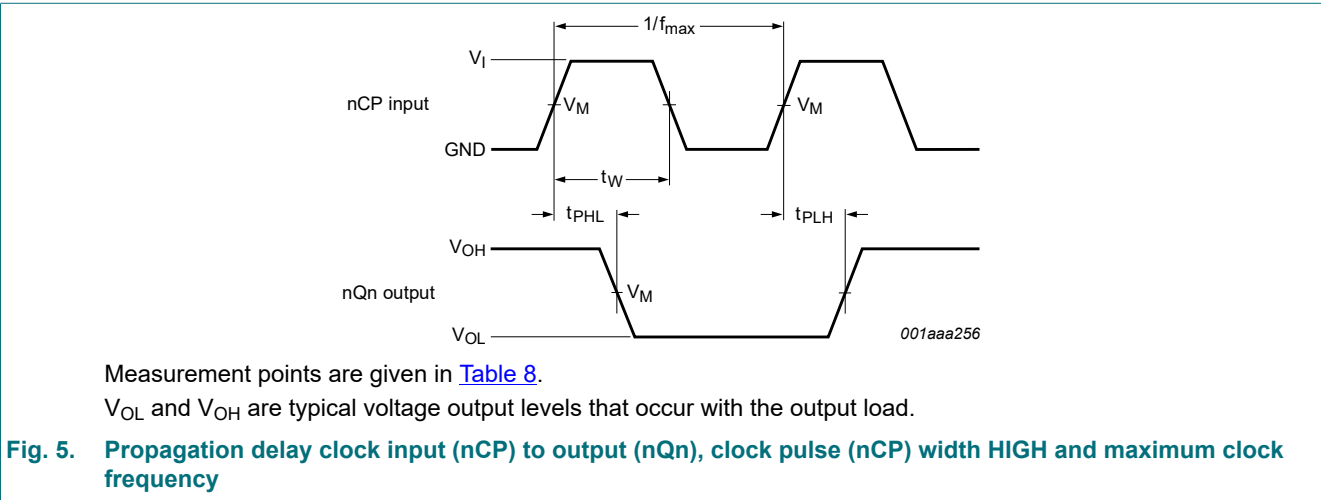*Voltages are referenced to GND (ground = 0 V); for test circuit see* Fig. 9.

Symbol	Parameter	Conditions	T_{amb} = −40 °C to +85 °C			Unit
			Min	Typ[1]	Max	
V_{CC} = 2.5 V ± 0.2 V						
t_{PLH}	LOW to HIGH propagation delay	nCP to nQn; see Fig. 5	1.5	2.9	4.5	ns
t_{PHL}	HIGH-to-LOW propagation delay	nCP to nQn; see Fig. 5	1.4	2.7	4.2	ns
		n$\overline{MR}$ to nQn; see Fig. 7	1.5	2.7	4.2	ns
t_{PZH}	OFF-state to HIGH propagation delay	n$\overline{OE}$ to nQn; see Fig. 8	2.1	3.4	5.0	ns
t_{PZL}	OFF-state to LOW propagation delay	n$\overline{OE}$ to nQn; see Fig. 8	1.8	3.0	4.7	ns
t_{PHZ}	HIGH to OFF-state propagation delay	n$\overline{OE}$ to nQn; see Fig. 8	1.7	3.0	4.3	ns
t_{PLZ}	LOW to OFF-state propagation delay	n$\overline{OE}$ to nQn; see Fig. 8	1.4	2.3	3.3	ns
$t_{su(H)}$	set-up time HIGH	nDn to nCP; see Fig. 6	1.0	0.5	-	ns
		n$\overline{CE}$ to nCP; see Fig. 6	1.0	0.2	-	ns
$t_{su(L)}$	set-up time LOW	nDn to nCP; see Fig. 6	1.8	1.3	-	ns
		n$\overline{CE}$ to nCP; see Fig. 6	0.5	-0.1	-	ns
$t_{h(H)}$	hold time HIGH	nDn to nCP; see Fig. 6	0.1	-1.4	-	ns
		n$\overline{CE}$ to nCP; see Fig. 6	1.0	0.2	-	ns
$t_{h(L)}$	hold time LOW	nDn to nCP; see Fig. 6	0.1	-0.5	-	ns
		n$\overline{CE}$ to nCP; see Fig. 6	1.0	-0.1	-	ns

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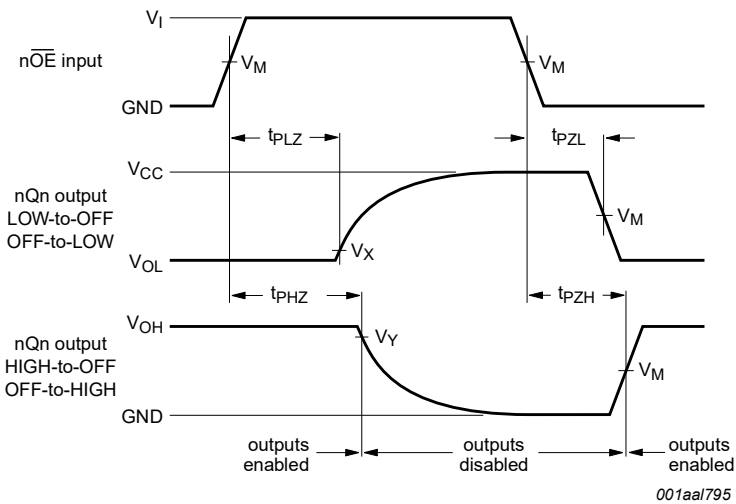**Product data sheet**

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18-bit bus-interface D-type flip-flop with reset and enable; 3-state

Symbol	Parameter	Conditions	T_{amb} = −40 °C to +85 °C			Unit
			Min	Typ[1]	Max	
t_{WH}	pulse width HIGH	nCP; see Fig. 5	2.0	0.8	-	ns
t_{WL}	pulse width LOW	nCP	3.0	2.1	-	ns
		n$\overline{MR}$; see Fig. 7	2.0	0.8	-	ns
t_{rec}	recovery time	n$\overline{MR}$ to nCP; see Fig. 7	2.0	1.3	-	ns
f_{max}	maximum frequency	CP; see Fig. 5	150	-	-	MHz
V_{CC} = 3.3 V ± 0.3 V						
t_{PLH}	LOW to HIGH propagation delay	nCP to nQn; see Fig. 5	1.0	2.3	3.1	ns
t_{PHL}	HIGH-to-LOW propagation delay	nCP to nQn; see Fig. 5	1.0	2.1	2.9	ns
		n$\overline{MR}$ to nQn; see Fig. 7	1.0	2.3	2.9	ns
t_{PZH}	OFF-state to HIGH propagation delay	n$\overline{OE}$ to nQn; see Fig. 8	1.7	2.7	4.0	ns
t_{PZL}	OFF-state to LOW propagation delay	n$\overline{OE}$ to nQn; see Fig. 8	1.4	2.3	3.5	ns
t_{PHZ}	HIGH to OFF-state propagation delay	n$\overline{OE}$ to nQn; see Fig. 8	2.2	3.1	4.0	ns
t_{PLZ}	LOW to OFF-state propagation delay	n$\overline{OE}$ to nQn; see Fig. 8	1.8	2.6	3.5	ns
$t_{su(H)}$	set-up time HIGH	nDn to nCP; see Fig. 6	1.0	0.5	-	ns
		n$\overline{CE}$ to nCP; see Fig. 6	1.0	0.1	-	ns
$t_{su(L)}$	set-up time LOW	nDn to nCP; see Fig. 6	1.6	1.1	-	ns
		n$\overline{CE}$ to nCP; see Fig. 6	0.5	-0.5	-	ns
$t_{h(H)}$	hold time HIGH	nDn to nCP; see Fig. 6	0.1	-0.7	-	ns
		n$\overline{CE}$ to nCP; see Fig. 6	1.0	0.5	-	ns
$t_{h(L)}$	hold time LOW	nDn to nCP; see Fig. 6	0.1	-0.5	-	ns
		n$\overline{CE}$ to nCP; see Fig. 6	1.0	-0.1	-	ns
t_{WH}	pulse width HIGH	nCP; see Fig. 5	1.5	0.7	-	ns
t_{WL}	pulse width LOW	nCP	2.5	1.4	-	ns
		n$\overline{MR}$; see Fig. 7	2.0	1.5	-	ns
t_{rec}	recovery time	n$\overline{MR}$ to nCP; see Fig. 7	2.0	1.1	-	ns
f_{max}	maximum frequency	CP; see Fig. 5	250	-	-	MHz

[1]   All typical values for V_{CC} = 2.5 V ± 0.2 V are measured at V_{CC} = 2.5 V and T_{amb} = 25 °C.
All typical values for V_{CC} = 3.3 V ± 0.3 V are measured at V_{CC} = 3.3 V and T_{amb} = 25 °C.

10.1. Waveforms and test circuit

Measurement points are given in Table 8.

V_{OL} and V_{OH} are typical voltage output levels that occur with the output load.

Fig. 5. **Propagation delay clock input (nCP) to output (nQn), clock pulse (nCP) width HIGH and maximum clock frequency**

Measurement points are given in Table 8.

The shaded areas indicate when the input is permitted to change for predictable output performance.

Fig. 6. **Data set-up and hold times**

Measurement points are given in Table 8.

V_{OL} and V_{OH} are typical voltage output levels that occur with the output load.

Fig. 7. **Master reset pulse width, master reset to output delay and master reset to clock recovery time**

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Measurement points are given in Table 8.

V_{OL} and V_{OH} are typical voltage output levels that occur with the output load.

Fig. 8. OFF-state to HIGH and LOW propagation delays and LOW and HIGH to OFF-state propagation delays

Table 8. Measurement points

V_{CC}	Input	Output		
	V_M	V_M	V_X	V_Y
≤ 2.7 V	0.5 x V_{CC}	0.5 x V_{CC}	V_{OL} + 0.15 V	V_{OH} - 0.15 V
≥ 3.0 V	1.5 V	1.5 V	V_{OL} + 0.3 V	V_{OH} - 0.3 V
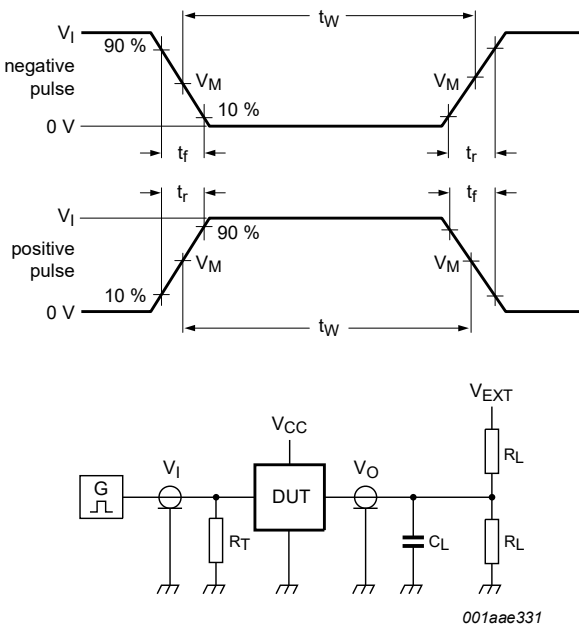
Test data is given in Table 9.

Definitions test circuit:

R_L = Load resistance;

C_L = Load capacitance including jig and probe capacitance;

R_T = Termination resistance should be equal to output impedance Z_o of the pulse generator;

V_{EXT} = Test voltage for switching times.

Fig. 9. Test circuit for measuring switching times

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Table 9. Test data

Input				Load		V_{EXT}		
V_I	f_i	t_W	t_r, t_f	C_L	R_L	t_{PHZ}, t_{PZH}	t_{PLZ}, t_{PZL}	t_{PLH}, t_{PHL}
3.0 V or V_{CC} whichever is less	≤ 10 MHz	500 ns	≤ 2.5 ns	50 pF	500 Ω	GND	6 V or V_{CC} × 2	open

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11. Package outline

TSSOP56: plastic thin shrink small outline package; 56 leads; body width 6.1 mm   **SOT364-1**

DIMENSIONS (mm are the original dimensions).

UNIT	A max.	A₁	A₂	A₃	bₚ	c	D[1]	E[2]	e	H_E	L	Lₚ	Q	v	w	y	Z	θ
mm	1.2	0.15 0.05	1.05 0.85	0.25	0.28 0.17	0.2 0.1	14.1 13.9	6.2 6.0	0.5	8.3 7.9	1	0.8 0.4	0.50 0.35	0.25	0.08	0.1	0.5 0.1	8° 0°

Notes

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT364-1		MO-153				~~99-12-27~~ 03-02-19

Fig. 10. Package outline SOT364-1 (TSSOP56)

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12. Abbreviations

Table 10. Abbreviations

Acronym	Description
ANSI	American National Standards Institute
BiCMOS	Bipolar Complementary Metal Oxide Semiconductor
CDM	Charged Device Model
DUT	Device Under Test
ESD	ElectroStatic Discharge
ESDA	ElectroStatic Discharge Association
HBM	Human Body Model
JEDEC	Joint Electron Device Engineering Council
TTL	Transistor-Transistor Logic

13. Revision history

Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74ALVT16823 v.7	20240625	Product data sheet	-	74ALVT16823 v.6
Modifications:	• Section 2: ESD specification updated according to the latest JEDEC standard.			
74ALVT16823 v.6	20201020	Product data sheet	-	74ALVT16823 v.5
Modifications:	• Type number 74ALVT16823DL (SOT371-1 / SSOP56) removed. • Section 1 and Section 2 updated.			
74ALVT16823 v.5	20180122	Product data sheet	-	74ALVT16823 v.4
Modifications:	• The format of this data sheet has been redesigned to comply with the identity guidelines of Nexperia. • Legal texts have been adapted to the new company name where appropriate.			
74ALVT16823 v.4	20050802	Product data sheet	-	74ALVT16823 v.3
Modifications:	• The format of this data sheet has been redesigned to comply with the new presentation and information standard of Philips Semiconductors. • Section 2: modified 'Jedec Std 17' into 'JESD78' • Section 10: changed propagation delays.			
74ALVT16823 v.3	19980612	Product specification	-	74ALVT16823 v.2
74ALVT16823 v.2	19980612	Product specification	-	74ALVT16823 v.1
74ALVT16823 v.1	19980303	Product specification	-	-

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14. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the internet at https://www.nexperia.com.

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